

**Search Notes**

Application/Control No.

10/527,699

Examiner

RIP A. LEE

Applicant(s)/Patent under  
Reexamination

KOBAYASHI ET AL.

Art Unit

1796

**SEARCHED**

Class	Subclass	Date	Examiner
502	339	1/22/2010	RL
502	173	1/22/2010	RL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
502	339	1/22/2010	RL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	1/22/2010	RL
palm - updated inventor search	1/22/2010	RL